

preliminary results of May 30, 2000 (65 FR 34440).

Final Results of Review

As a result of this review, the Department finds that termination of the suspended antidumping investigation on silicomanganese from Ukraine would be likely to lead to continuation or recurrence of dumping at the level listed below:

Manufacturers/Exporters	Margin (percent)
Country-wide	163.00

This notice also serves as the only reminder to parties subject to administrative protective orders ("APO") of their responsibility concerning the return or disposition of proprietary information disclosed under APO in accordance with 19 CFR 351.305 of the Department's regulations. Timely written notification of the return or destruction of APO materials or conversion to judicial protective order is hereby requested. Failure to comply with the regulations and terms of an APO is a violation which is subject to sanction.

This five-year ("sunset") review and notice are in accordance with sections 751(c), 752, and 777(i)(1) of the Act.

Dated: September 21, 2000.

Troy H. Cribb,

Acting Assistant Secretary for Import Administration.

[FR Doc. 00-24848 Filed 9-26-00; 8:45 am]

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DEPARTMENT OF COMMERCE

International Trade Administration

Applications for Duty-Free Entry of Scientific Instruments

Pursuant to section 6(c) of the Educational, Scientific and Cultural Materials Importation Act of 1966 (Pub. L. 89-651; 80 Stat. 897; 15 CFR part 301), we invite comments on the question of whether instruments of equivalent scientific value, for the purposes for which the instruments shown below are intended to be used, are being manufactured in the United States.

Comments must comply with 15 CFR 301.5(a)(3) and (4) of the regulations and be filed within 20 days with the Statutory Import Programs Staff, U.S. Department of Commerce, Washington, DC 20230. Applications may be examined between 8:30 A.M. and 5:00 P.M. in Room 4211, U.S. Department of

Commerce, 14th Street and Constitution Avenue, NW, Washington, DC.

Docket Number: 00-021. *Applicant:* University of Florida, Materials Science and Engineering, Post Office Box 116400, Gainesville, FL 32611-6400.

Instrument: Electron Microscope, Model JEM-2010F. *Manufacturer:* JEOL Ltd., Japan. *Intended Use:* The instrument is intended to be used to study the microstructure of metals, metal alloys, ceramics, high-temperature superconductors, semiconductors, polymers, clays, dental implants and soot emissions while conducting the following representative experiments:

1. Structure-property relationships in semiconducting materials.
2. Interface phenomena in oxides.
3. Analysis of interfaces in advanced polymers and photonic devices.
4. The structure of high-temperature materials.
5. Mechanical properties of dental implants.
6. Polymer-protein and polymer-cell interactions.
7. Nanoscale properties of porous silicon.
8. Structure and chemistry of oxide minerals.
9. Structure-property relationships in opto-electronic materials.
10. Strength/hardness enhancement in superlattices.

In addition, the instrument will be used on a one-to-one basis for training of faculty, staff and graduate students. Application accepted by Commissioner of Customs: June 9, 2000.

Docket Number: 00-027. *Applicant:* Emory University, Department of Biology, 2006 Rollins Research Center, 1510 Clifton Road, Atlanta, GA 30322. *Instrument:* Slice Physiology Setup. *Manufacturer:* Luigs and Neumann, Germany. *Intended Use:* The instrument is intended to be used to do electrophysiological studies using rat brain slices. The experiments consist of preparing slices of rat brain, putting them under the microscope and inserting microelectrodes into single nerve cells. Once the microelectrode is inserted, a fluorescent dye will be injected into the cell body to visualize fine dendritic processes. The microscope will then be moved to focus on one of the visualized fine processes, and a second electrode can be inserted into the same cell. The main objective of this research is to understand neuronal activity and information processing in the mammalian brain. In particular, nerve cells in brain structures involved in a motor control will be studied. In addition, the instrument will be used for educational

purposes in the course Bio. 498 Guided Research for Senior Undergraduate Students. Application accepted by Commissioner of Customs: September 5, 2000.

Docket Number: 00-028. *Applicant:* Ernest Orlando Lawrence Berkeley National Laboratory, One Cyclotron Road, Berkeley, CA 94720. *Instrument:* Electron Microscope, Model JEM-3010. *Manufacturer:* JEOL Ltd., Japan. *Intended Use:* The instrument is intended to be used for studies of the microstructure and microstructural evolution of metals, metal alloys, ceramics, electronic and opto-electronic materials and nanocomposites. The experiments will include:

1. In-situ microscopy—real time evolutions of structure/property/processing relationships.
2. Real time high-resolution electron microscopy.
3. Dislocation and defect studies in materials.
4. Identification of phases and crystal structure by electron diffraction and convergent beam electron diffraction.

In addition, the instrument will be used for significant one-to-one educational use between the staff and users on how to exploit transmission electron microscopy to solve materials problems. Application accepted by Commissioner of Customs: September 5, 2000.

Frank W. Creel,

Director, Statutory Import Programs Staff.

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DEPARTMENT OF COMMERCE

National Oceanic and Atmospheric Administration

[I.D. 092100D]

Mid-Atlantic Fishery Management Council; Public Meetings

AGENCY: National Marine Fisheries Service (NMFS), National Oceanic and Atmospheric Administration (NOAA), Commerce.

ACTION: Notice of public meeting.

SUMMARY: The Mid-Atlantic Fishery Management Council (MAFMC) and its Comprehensive Management Committee, Executive Committee, Law Enforcement Committee, Demersal Committee, Squid-Mackerel-Butterfish Committee, and Habitat Committee will hold a public meeting.

DATES: The meetings will be held on Tuesday, October 10, 2000, to Thursday, October 12, 2000.